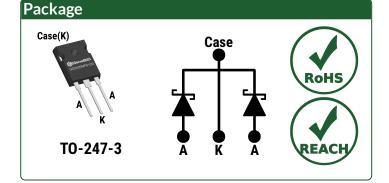
Silicon Carbide Schottky Diode



V _{RRM}	=	1200 V
IF(T _C = 151°C)	=	40 A *
Qc	=	130 nC *

Features

- Gen4 Thin Chip Technology for Low VF
- Superior Figure of Merit Qc*VF
- 100% Avalanche (UIL) Tested
- Enhanced Surge Current Withstand Capability
- Temperature Independent Fast Switching
- Low Thermal Resistance
- Positive Temperature Coefficient of V_F
- High dV/dt Ruggedness



Advantages

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Enables Extremely Fast Switching

Applications

- Power Factor Correction (PFC)
- Electric Vehicles and Battery Chargers
- Solar Inverters
- High Frequency Converters
- Switched Mode Power Supply (SMPS)
- Motor Drives
- Anti-Parallel / Free-Wheeling Diode
- Induction Heating & Welding

Absolute Maximum Ratings (At T_c = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Repetitive Peak Reverse Voltage (Per Leg)	V _{RRM}		1200	V	
		T _C = 100°C, D = 1	39 / 78		
Continuous Forward Current (Per Leg / Per Device)	IF	T _C = 135°C, D = 1	27 / 54	Α	Fig. 4
		T _C = 151°C, D = 1	20 / 40		
Non-Repetitive Peak Forward Surge Current, Half Sine	Irou	T _C = 25°C, t _P = 10 ms	160	٨	
Wave (Per Leg)	IF,SM	T _C = 150°C, t _P = 10 ms	128	А	
Repetitive Peak Forward Surge Current, Half Sine Wave	lenu	T _C = 25°C, t _P = 10 ms	96	А	
(Per Leg)	I _{F,RM}	T _C = 150°C, t _P = 10 ms	67	A	
Non-Repetitive Peak Forward Surge Current (Per Leg)	I _{F,MAX}	T _C = 25°C, t _P = 10 μs	800	А	
i²t Value (Per Leg)	∫i²dt	T _C = 25°C, t _P = 10 ms	128	A ² s	
Non-Repetitive Avalanche Energy (Per Leg)	E _{AS}	L = 0.9 mH, I _{AS} = 20 A	181	mJ	
Diode Ruggedness (Per Leg)	dV/dt	V _R = 0 ~ 960 V	200	V/ns	
Power Dissipation (Per Leg / Per Device)	Ртот	T _C = 25°C	234 / 468	W	Fig. 3
Operating and Storage Temperature	Tj, Tstg		-55 to 175	°C	

* Per Device



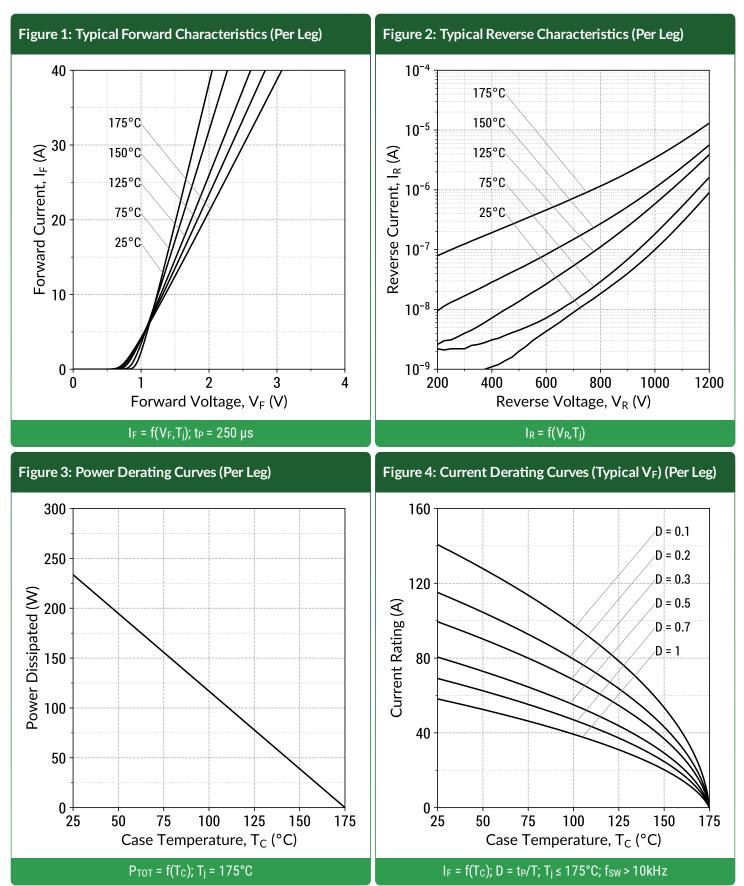
Electrical Characteristics (Per Leg)

Parameter	Symbol	Conditions		Values			11	Note
Paralleler	Symbol			Min.	Тур.	Max.	- Unit	Note
Diada Farward Valtaga	VF	I _F = 20 A, T _j = 25°C			1.5	1.8	V	Fig. 1
Diode Forward Voltage	VF	I _F = 20 A, T _j = 175°C			1.9			
Deverse Current	I_	V _R = 1200 V, T _j = 25°C			1	10		Fig. 2
Reverse Current	IR	V _R = 1200 V, T _j = 175°C			14		μA	
Tatal Canaditive Change	0		V _R = 400 V		45		-0	Fig. 7
Total Capacitive Charge	Qc	I _F ≤ I _{F,MAX}	V _R = 800 V		65	nC	Fig. 7	
Quitabing Time	_	dl _F /dt = 200 A/µs	V _R = 400 V		. 10			
Switching Time	ts		V _R = 800 V		< 10		ns	
Tatal Canaditanaa	0	V _R = 1 V, f = 1MHz			737		<u>"Г</u>	Fig. 6
Total Capacitance	С	V _R = 800 V, f = 1MHz			43		pF	

Thermal/Package Characteristics

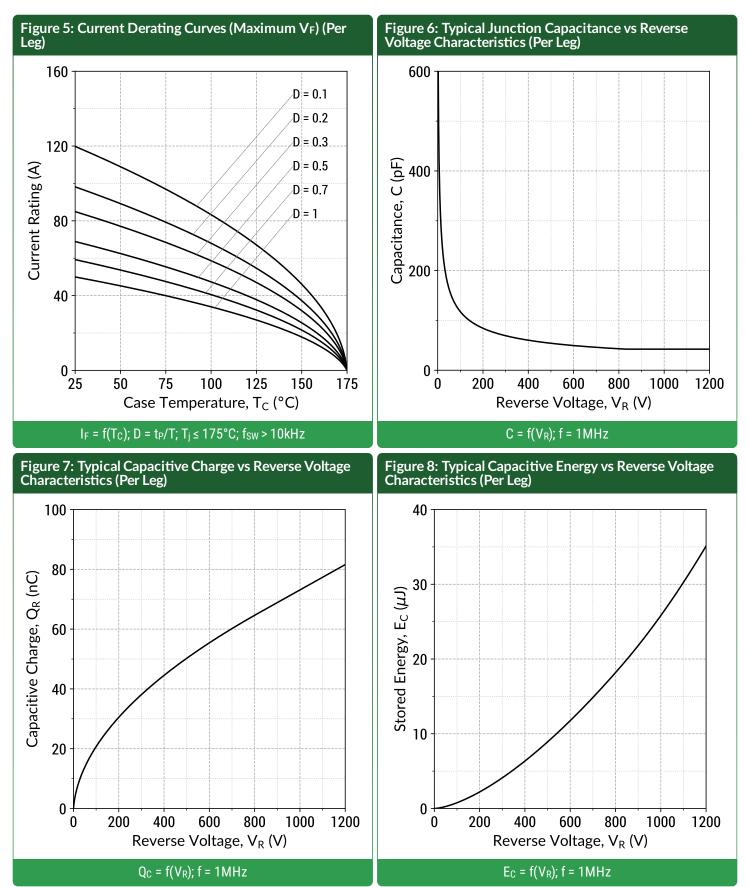
Deremeter	Symbol	Conditions		Values			Note
Parameter	Symbol		Min.	Тур.	Max.	- Unit	Note
Thermal Resistance, Junction - Case (Per Leg)	RthJC			0.64		°C/W	Fig. 9
Weight	WT			6.1		g	
Mounting Torque	T _M	Screws to Heatsink			1.1	Nm	





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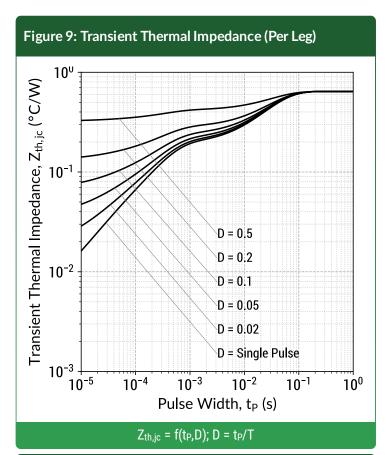
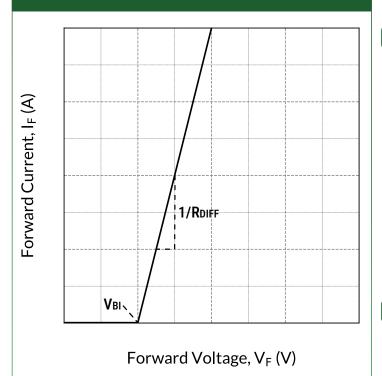


Figure 10: Forward Curve Model (Per Leg)



 $I_F = f(V_F, T_j)$

Forward Curve Model Equation:

 $I_F = (V_F - V_{BI})/R_{DIFF} (A)$

Built-In Voltage (V_{BI}):

$$V_{Bl}(T_j) = m \times T_j + n (V)$$

m = -0.00119 (V/°C)
n = 1.01 (V)

Differential Resistance (RDIFF):

 $R_{DIFF}(T_j) = a \times T_j^2 + b \times T_j + c (\Omega)$ a = 5.93e-07 (\Omega/\circ{C}^2) b = 8.21e-05 (\Omega/\circ{C}) c = 0.0244 (\Omega)

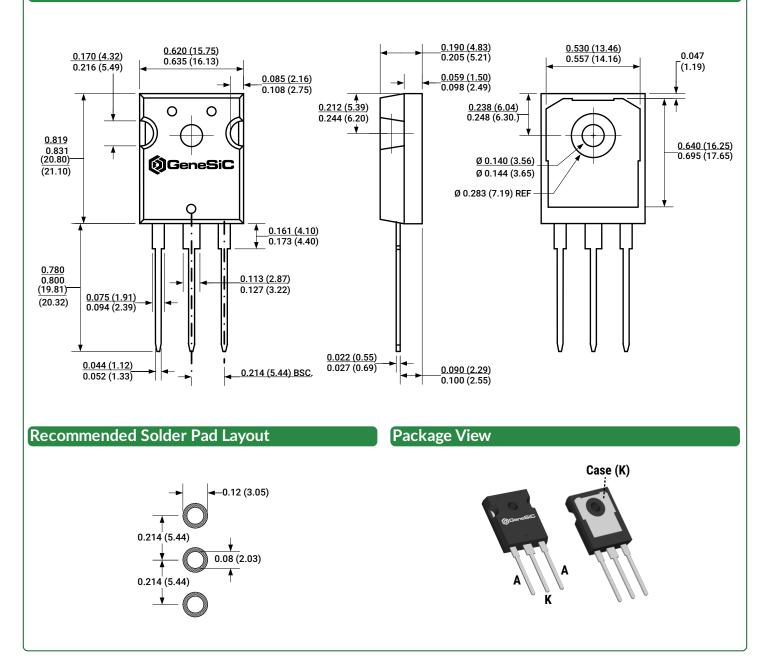
Forward Power Loss Equation:

 $P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$



Package Dimensions

TO-247-3 Package Outline



NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.



Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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Related Links

SPICE Models:	https://www.genesicsemi.com/sic-schottky-mps/GD2X20MPS12D/GD2X20MPS12D_SPICE.zip				
• PLECS Models:	https://www.genesicsemi.com/sic-schottky-mps/GD2X20MPS12D/GD2X20MPS12D_PLECS.zip				
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Compliance:	https://www.genesicsemi.com/compliance				
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Revision History

Jul. 27, 2020: Initial Release



www.genesicsemi.com/sic-schottky-mps/



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